

<b>Notice of References Cited</b>	Application/Control No. 10/648,118		Applicant(s)/Patent Under Reexamination CHEE ET AL.	
	Examiner Nathan W. Ha		Art Unit 2814	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0190259 a1	09-2004	Labanok et al.	361/704
*	B	US-2004/0251538 a1	12-2004	Lin et al.	257/712
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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